
PXle-5820 Specifications

2022-10-31

Contents

PXIe-5820 Specifications..... 3

PXIe-5820 Specifications

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- **Typical** specifications describe the performance met by a majority of models.
- **Typical-95** specifications describe the performance met by 95% ($\approx 2\sigma$) of models with a 95% confidence.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are **Warranted** unless otherwise noted.

Conditions

Warranted specifications are valid under the following conditions unless otherwise noted.

- Over ambient temperature range of 0 °C to 45 °C.
- 30 minutes warm-up time.
- Calibration cycle is maintained.
- Chassis fan speed is set to High. In addition, NI recommends using slot blockers and EMC filler panels in empty module slots to minimize temperature drift.
- Calibration IP is used properly during the creation of custom FPGA bitfiles.

Typical specifications do not include measurement uncertainty and are measured immediately after a device self-calibration is performed.

Unless otherwise noted, specifications assume the PXIe-5820 is configured in the following default mode of operation:

- I/Q IN voltage range: 2.0 V_{pk-pk} differential
- I/Q IN common-mode voltage: 0 V
- I/Q OUT voltage range: 1.0 V_{pk-pk} differential
- I/Q OUT common-mode voltage: 0 V
- I/Q OUT load impedance: 100 Ω differential

Note Within the specifications, **self-calibration °C** refers to the recorded device temperature of the last successful self-calibration. You can read the self-calibration temperature from the device using the appropriate software functions.

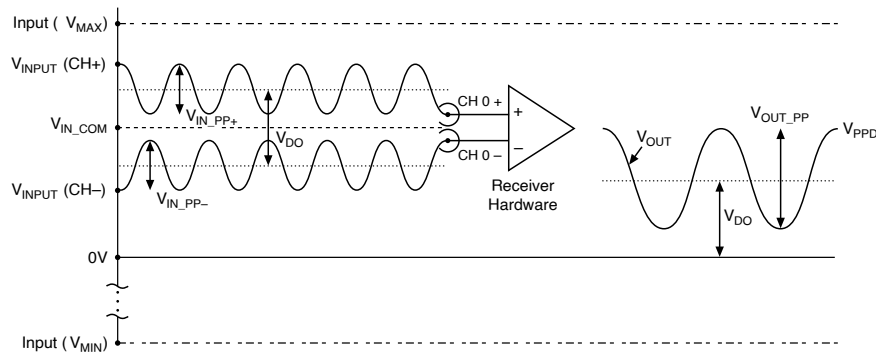
Differential Operation

The I/Q inputs and outputs of the PXIe-5820 support differential operation. This section explains some of the fundamental analog signal processing that occurs in the first stages of the I/Q receiver.

A differential signal system has a positive component ($V_{\text{INPUT}}(\text{CH}+)$) and a negative component ($V_{\text{INPUT}}(\text{CH}-)$). The differential signal can have a common-mode offset ($V_{\text{IN_COM}}$) shared by both $V_{\text{INPUT}}(\text{CH}+)$ and $V_{\text{INPUT}}(\text{CH}-)$. The differential input signal is superimposed on the common-mode offset. The input circuitry rejects the input common-mode offset signal.

In a differential system, any noise present on both $V_{\text{INPUT}}(\text{CH}+)$ and $V_{\text{INPUT}}(\text{CH}-)$ gets rejected. Differential systems also double the dynamic range compared to a single-ended system with the same voltage swing. The following figure illustrates the key concepts of differential offset and common-mode offset associated with a differential system.

Figure 1. Definition of Common-Mode Offset and Differential Offset



where

- V_{IN_PP+} represents the peak-to-peak amplitude of the positive AC input signal
- V_{IN_PP-} represents the peak-to-peak amplitude of the negative AC input signal
- V_{DO} represents the differential offset voltage
- V_{IN_COM} represents the common-mode offset voltage
- V_{OUT_PP} represents the peak-to-peak amplitude of the output signal

In the previous figure, the input common-mode voltage is not present after the first stage of the receiver system. The signal remaining at the output of the receiver circuitry is the signal of interest.

Note The differential signal can have an offset between $V_{INPUT(CH+)}$ and $V_{INPUT(CH-)}$. This is known as the **differential offset** and is retained by the receiver circuitry.

In an I/Q analyzer, a differential offset can occur because of LO leakage or harmonics. In the case of I/Q generation, a differential offset can cause spurs and magnitude error.

In a phase-balanced differential system, the peak-to-peak amplitude of the positive AC input signal (V_{IN_PP+}) is equal to the peak-to-peak amplitude of the negative AC input signal (V_{IN_PP-}). The AC peak-to-peak amplitude of the output signal is the sum

of V_{IN_PP+} and V_{IN_PP-} . A more general definition for the output voltage regardless of phase is the difference between V_{IN_PP+} and V_{IN_PP-} described by the following equation:

$$V_{OUT} = (V_{INPUT(CH+)}) - (V_{INPUT(CH-)})$$

The common-mode offset, which represents the rejected component common to both signals, is described by the following equation:

$$V_{IN_COM} = [(V_{INPUT(CH+)}) + (V_{INPUT(CH-)})]/2$$

Frequency

Complex I/Q equalized bandwidth ^[1]	1 GHz
Frequency Range	DC-500 MHz

Note To operate the device in complex baseband mode, configure each channel with identical ranges and termination. Complex baseband mode requires two input signals that are 90° out of phase.

Internal Frequency Reference

Initial adjustment accuracy	$\pm 200 \times 10^{-9}$
Temperature stability	$\pm 1 \times 10^{-6}$, maximum
Aging	$\pm 1 \times 10^{-6}$ per year, maximum
Accuracy	Initial adjustment accuracy \pm Aging \pm Temperature stability

I/Q Input

I/Q Input Common-Mode Accuracy

Common-Mode (V)	Accuracy (mV) at 23 °C
-0.25 to 1.50	±2.5
Conditions: Measured with a DMM. Common-mode offset is not adjusted during self-calibration. Valid for vertical ranges between 0.1 V _{pp} and 2.0 V _{pp} , differential. Measured with both input terminals terminated to ground through a high impedance >1 MΩ.	

Table 29. I/Q Input Common-Mode Accuracy, Typical

I/Q Input DC Offset

Reference Location	DC Offset at 23 °C ± 5 °C
At ADC	<-57 dBFS
At connector	<10 mV
Conditions: Terminated with 100 Ω differential impedance.	

Table 2. I/Q Input Differential DC Offset Error, Typical

I/Q Input Absolute AC Gain Accuracy

Input Vertical Range (V _{pp} , Differential)	23 °C ± 5 °C	0 °C to 45 °C
	0.5 to 4.0	±0.57 ±0.15, typical
1.0 to 4.0	±0.44	±0.57
Conditions: Valid for all common-mode voltages. Measured with 10 MHz CW tone from a 100 Ω differential source.		

Input Vertical Range (V_{pp} , Differential)	23 °C ± 5 °C	0 °C to 45 °C
This specification is valid only when the module is operating within the specified ambient temperature range and within ±5 °C from the last self-calibration temperature, as indicated by the niRFSA Device Temperature property or NIRFSA_ATTR_DEVICE_TEMPERATURE attribute.		

Table 30. I/Q Input Absolute AC Gain Accuracy (dB)

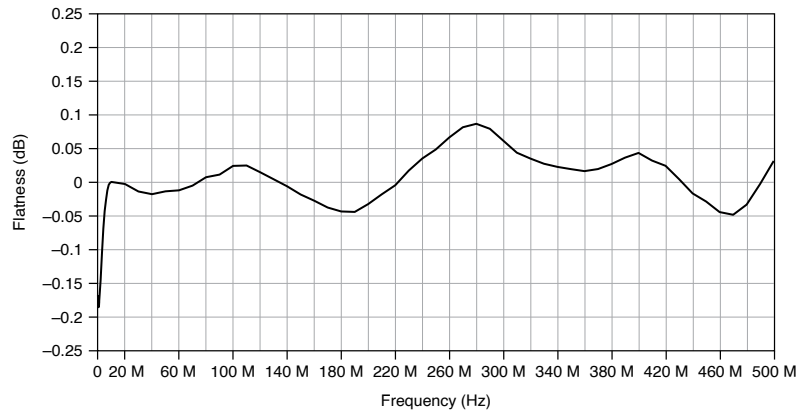
I/Q Input Frequency Response

Frequency	Input Vertical Range (V_{pp} , Differential)	23 °C ± 5 °C	0 °C to 45 °C
100 kHz to 100 MHz	0.5 to 4.0	±0.31, typical	±0.36, typical
		±0.82	±0.92
100 kHz to 250 MHz	0.5 to 4.0	±0.31, typical	±0.36, typical
		±0.82	±0.97
100 kHz to 500 MHz	0.5 to 4.0	±0.31, typical	±0.62, typical
		±0.82	±1.22
10 MHz to 250 MHz	0.5 to 4.0	±0.10, typical	±0.28, typical
		±0.25, typical	±0.62, typical
10 MHz to 500 MHz	1.0 to 4.0	±0.67	±0.77
100 kHz to 100 MHz	1.0 to 4.0	±0.67	±0.77
		±0.67	±0.83
100 kHz to 250 MHz	1.0 to 4.0	±0.67	±0.83
		±0.68	±1.10

Conditions: Valid for all common-mode voltages. Referenced to 10 MHz.

This specification is the individual I or Q channel flatness and is valid only when the module is operating within the specified ambient temperature range and within ±5 °C from the last self-calibration temperature, as indicated by the niRFSA Device Temperature property or the NIRFSA_ATTR_DEVICE_TEMPERATURE attribute.

Table 4. I/Q Input Frequency Response^[2] (dB)

Figure 2. I/Q Input Frequency Response, Nominal^[3]

I/Q Input Settling Time

Proximity to Final Settled Value (dB)	Settling Time (μ s)
0.5	9
0.1	100
0.05	100
0.01	100

Table 5. I/Q Input Amplitude Settling Times, Nominal

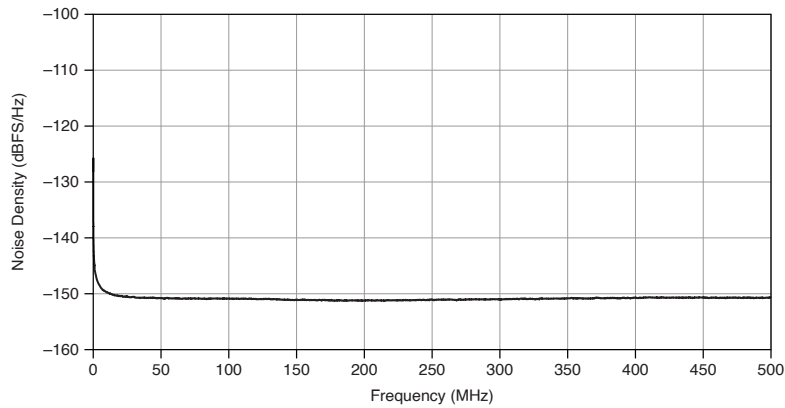
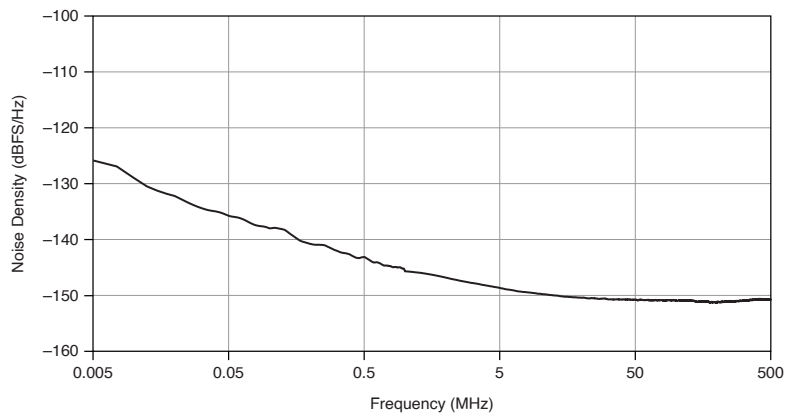
Nominal common-mode voltage settling time (0.01 dB) ^[4]	1.2 ms
--	--------

I/Q Input Average Noise Density

Input Vertical Range (V_{pp} , Differential)	dBm/Hz	dBFS/Hz
0.5	-152	-149
1	-143	-146
2	-141	-149
3	-140	-150

Conditions: Terminated with a 100 Ω differential impedance.

Table 6. I/Q Average Input Noise Density, Typical

Figure 3. Input Average Noise Density vs. Linear Frequency (dBFS/Hz), Nominal [\[5\]](#)Figure 4. Input Average Noise Density vs. Log Frequency (dBFS/Hz), Nominal [\[6\]](#)

I/Q Input Spectral Characteristics

Harmonics [\[7\]](#)

Input Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-74	-78	-76	-80
1	-75	-80	-76	-83
2	-76	-81	-73	-80
3	-78	-80	-73	-79

Table 20. I/Q Input I Channel Highest Harmonic Spur Level (dBc)

Input Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-78	-81	-78	-81
1	-80	-85	-82	-86
2	-79	-82	-80	-85
3	-77	-80	-79	-84

Table 8. I/Q Input Q Channel Highest Harmonic Spur Level (dBc)

Input Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-74	-77	-75	-79
1	-75	-80	-75	-82
2	-76	-80	-73	-79
3	-77	-79	-73	-79

Table 21. I/Q Input I Channel THD (dBc)

Input Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-76	-79	-77	-81
1	-80	-84	-81	-85
2	-79	-81	-79	-84
3	-76	-79	-78	-83

Table 10. I/Q Input Q Channel THD (dBc)

Input Vertical Range (V_{pp} , Differential)	10 MHz	100 MHz
0.5	-89	-89
1	-89	-88
2	-89	-89
3	-89	-88

Table 22. I/Q Input Second Harmonic (dBc), Nominal

Input Vertical Range (V_{pp} , Differential)	10 MHz	100 MHz
0.5	-88	-91

Input Vertical Range (V_{pp} , Differential)	10 MHz	100 MHz
1	-89	-89
2	-86	-85
3	-86	-84

Table 23. I/Q Input Third Harmonic (dBc), Nominal

Nonharmonics^[8]

Input Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-80	-82	-79	-81
1	-79	-81	-79	-81
2	-80	-81	-79	-81
3	-80	-81	-80	-82

Table 13. I/Q Input Nonharmonics (dBc)

I/Q Output

I/Q Output Common-Mode Accuracy

Common-Mode (V)	Accuracy (mV) at 23 °C
-0.25 to 1.50	±2
Conditions: Measured with a DMM. Common-mode offset is not adjusted during self-calibration. Valid for vertical ranges between 0.1 V_{pp} and 2.0 V_{pp} , differential. Measured with both output terminals terminated to ground through a high impedance >1 M Ω .	

Table 29. I/Q Output Common-Mode Accuracy, Typical

I/Q Output DC Offset

Temperature Range	I/Q Output DC Offset Error
23 °C ± 5 °C	-60

Temperature Range	I/Q Output DC Offset Error
dBr is dB relative to the peak to peak output voltage setting (V_{pp} , differential).	

Table 15. I/Q Output Differential DC Offset Error^[9] (dBr), Typical

I/Q Output Absolute AC Gain Accuracy

Output Vertical Range (V_{pp} , Differential)	23 °C ± 5 °C	0 °C ± 45 °C
0.25 to 2.0	±0.43	±0.68
	±0.10, typical	±0.35, typical

Conditions: Valid for all common-mode voltages. 10 MHz CW tone into a 100 Ω differential load.

This specification is valid only when the module is operating within the specified ambient temperature range and within ± 5 °C from the last self-calibration temperature, as indicated by the niRFSG Device Temperature property or the NIRFSA_ATTR_DEVICE_TEMPERATURE attribute.

Table 30. I/Q Output Absolute AC Gain Accuracy (dB)

I/Q Output Frequency Response

Frequency Range	Output Vertical Range (V_{pp} , Differential)	23 °C ± 5 °C	0 °C to 45 °C
100 kHz to 100 MHz	0.25 to 2.0	±0.17, typical	±0.24, typical
		±0.51	±0.61
100 kHz to 250 MHz	0.50 to 2.0	±0.44	±0.54
	0.25 to 2.0	±0.17, typical	±0.25, typical
		±0.57	±0.69
100 kHz to 500 MHz	0.25 to 2.0	±0.55	±0.68
		±0.18, typical	±0.36, typical
	0.50 to 2.0	±0.65	±0.83
	0.25 to 2.0	±0.59	±0.80

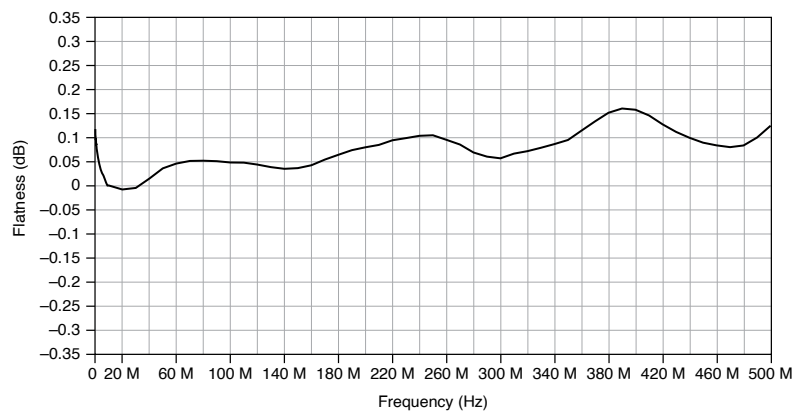
Conditions: Valid for all common-mode voltages. Referenced to 10 MHz.

Frequency Range	Output Vertical Range (V_{pp} , Differential)	$23\text{ }^{\circ}\text{C} \pm 5\text{ }^{\circ}\text{C}$	$0\text{ }^{\circ}\text{C}$ to $45\text{ }^{\circ}\text{C}$
-----------------	--	--	---

This specification is the individual I or Q channel flatness and is valid only when the module is operating within the specified ambient temperature range and within $\pm 5\text{ }^{\circ}\text{C}$ from the last self-calibration temperature, as indicated by the niRFSG Device Temperature property or the NIRFSA_ATTR_DEVICE_TEMPERATURE attribute.

Table 29. I/Q Output Frequency Response (dB)

Figure 5. I/Q Output Frequency Response, Nominal^[10]



I/Q Output Settling Time

Proximity to Final Settled Value (dB)	Settling Time (us)
0.5	9
0.1	100
0.05	100
0.01	100

Table 30. I/Q Output Nominal Amplitude Settling Times

Nominal common-mode settling time (0.01 dB) ^[11]	1.2 ms
---	--------

I/Q Output Average Noise Density

Output Vertical Range (V_{pp} , Differential)	dBm/Hz	dBFS/Hz
0.5	-152	-147
1	-154	-155
2	-156	-162

Conditions: Terminated with a 100 Ω differential impedance.

Table 19. I/Q Average Output Noise Density, Typical

I/Q Output Spectral Characteristics

Harmonics^[12]

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-77	-80	-70	-74
1	-78	-80	-69	-74
2	-69	-71	-66	-68

Table 20. I/Q Output I or Q Channel Highest Harmonic Spur Level (dBc)

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-75	-78	-69	-73
1	-77	-78	-69	-73
2	-69	-70	-65	-67

Table 21. I/Q Output I or Q Channel THD (dBc)

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-72	-82	-67	-77
1	-73	-81	-68	-77

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
2	-74	-82	-66	-76

Table 22. I/Q Output I or Q Channel Second Harmonic (dBc)

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-73	-81	-69	-78
1	-79	-85	-73	-80
2	-72	-75	-65	-71

Table 23. I/Q Output I or Q Channel Third Harmonic (dBc)

Nonharmonics^[13]

Output Vertical Range (V_{pp} , Differential)	10 MHz		100 MHz	
	Typical	Nominal	Typical	Nominal
0.5	-76	-77	-75	-77
1	-79	-81	-79	-81
2	-80	-82	-79	-81

Table 25. I/Q Loopback Nonharmonics

Additional Performance Information

Image Suppression

Complex Bandwidth	Image Suppression
200 MHz	-69
1 GHz	-61

Image suppression is equivalent to or better than the specification at all frequency offsets within the specified bandwidth.

Table 25. I/Q Loopback Image Suppression^[14] (dBc), Nominal

SINAD and ENOB

Real Bandwidth (MHz)	Real SINAD	Real ENOB	Complex SINAD	Complex ENOB
0.5	80.1	13.0	80.5	13.1
1	79.9	13.0	80.4	13.1
2.5	79.7	13.0	80.3	13.1
5	78.8	12.8	79.4	12.9
10	77.9	12.6	78.4	12.7
20	77.7	12.6	78.3	12.7
100	76.3	12.4	77.4	12.6
500	69.5	11.3	70.6	11.4

Complex equalized bandwidth is the combined bandwidth of I and Q channels.

Table 30. Input SINAD and ENOB

Real Bandwidth (MHz)	Real SINAD	Real ENOB	Complex SINAD	Complex ENOB
0.5	79.3	12.9	80.5	13.1
1	78.7	12.8	80.1	13.0
2.5	75.8	12.3	77.9	12.6
5	76.8	12.5	78.7	12.8
10	75.8	12.3	77.9	12.6
20	74.3	12.0	76.8	12.5
100	69.7	11.3	72.5	11.8
500	63.6	10.3	66.6	10.8

Complex equalized bandwidth is the combined bandwidth of I and Q channels.

Table 27. Output SINAD and ENOB

I/Q Loopback Third-Order Intermodulation (IMD3)

Vertical Range (V_{pp} , Differential)	0 °C to 45 °C	
	Center Frequency (MHz)	
	10 MHz	100 MHz
0.25	-77	-77

Vertical Range (V_{pp} , Differential)	0 °C to 45 °C	
	Center Frequency (MHz)	
	10 MHz	100 MHz
0.50	-77	-77
1.00	-78	-76
2.00	-73	-72

Conditions: Measured in loopback with two-tone stimulus, each tone is -8 dBFS with a 700 kHz spacing between the tones (equally spaced from the center frequency). IQ In and IQ Out ports are configured with the same Vertical Range and with 0 V common-mode.

Table 29. I/Q Loopback IMD3 (dBc), Typical

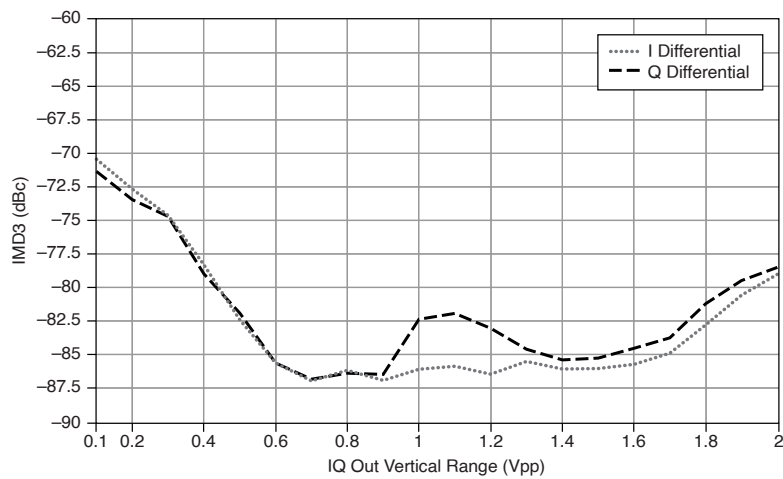
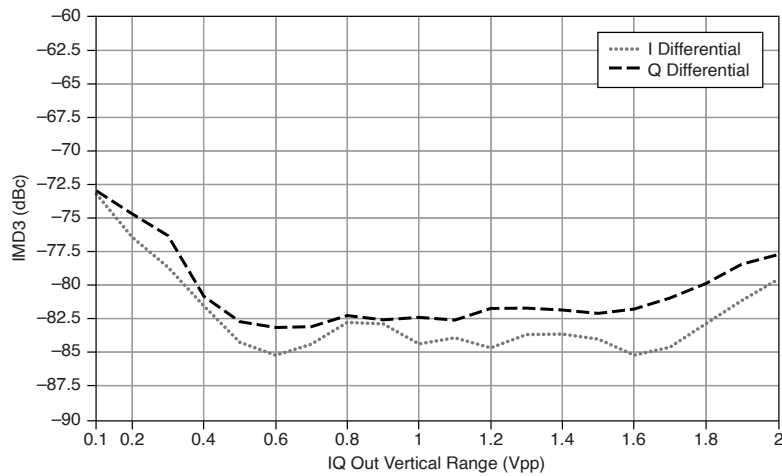
Figure 6. 10 MHz IMD3, Nominal^[15]

Figure 7. 100 MHz IMD3, Nominal^[16]

I/Q Loopback Second-Order Intermodulation (IMD2)

Vertical Range (V _{pp} , Differential)	0 °C to 45 °C	
	Center Frequency (MHz)	
	10 MHz	100 MHz
0.25	-74	-68
0.50	-73	-67
1.00	-73	-68
2.00	-73	-67

Conditions: Measured in loopback with two-tone stimulus, each tone is -8 dBFS with a 700 kHz spacing between the tones (equally spaced from the center frequency). IQ In and IQ Out ports are configured with the same Vertical Range and with 0 V common-mode.

Table 29. I/Q Loopback IMD2 (dBc), Typical

Figure 8. 10 MHz IMD2, Nominal^[17]

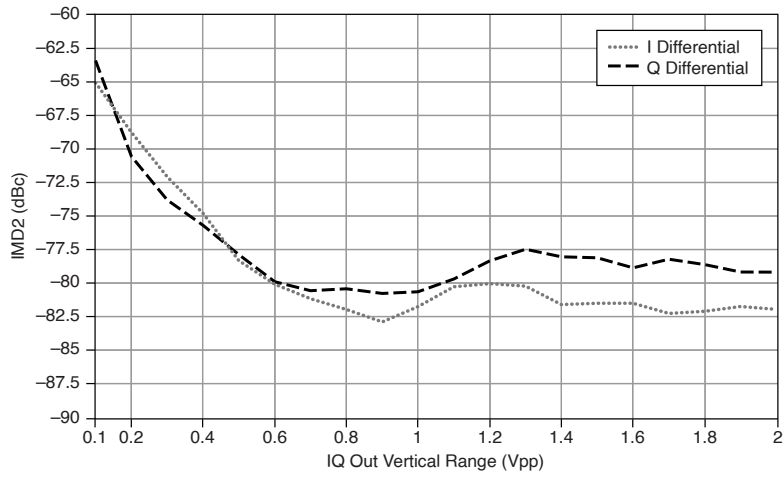
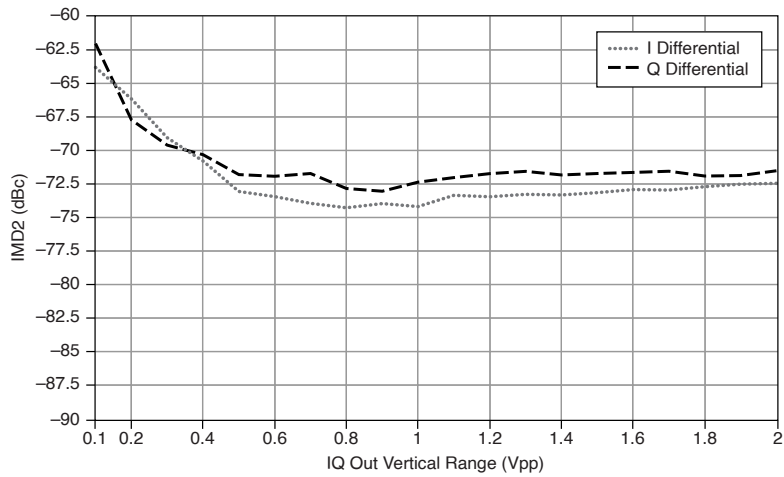


Figure 9. 100 MHz IMD2, Nominal^[18]



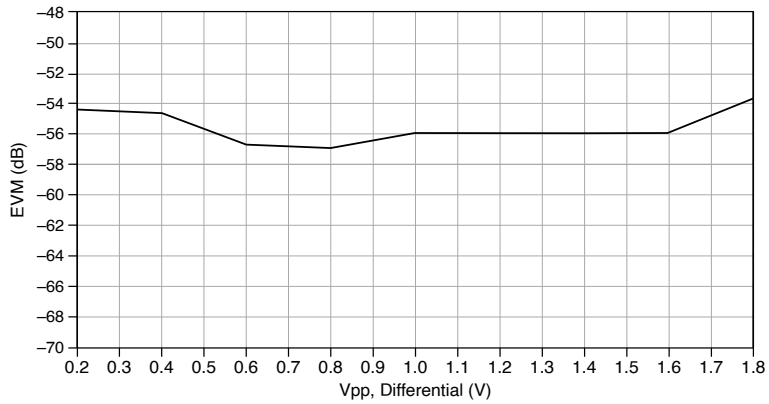
Application-Specific Modulation Quality

WLAN 802.11ax

EVM (Bandwidth: 80 MHz)^[19]

-50 dB, typical

Figure 10. 802.11ax Measured EVM (80 MHz)



WLAN 802.11ac

EVM (Bandwidth: 80 MHz) ^[20]	-50 dB, typical
EVM (Bandwidth: 160 MHz) ^[21]	-50 dB, typical

Figure 11. 802.11ac Measured EVM (80 MHz)

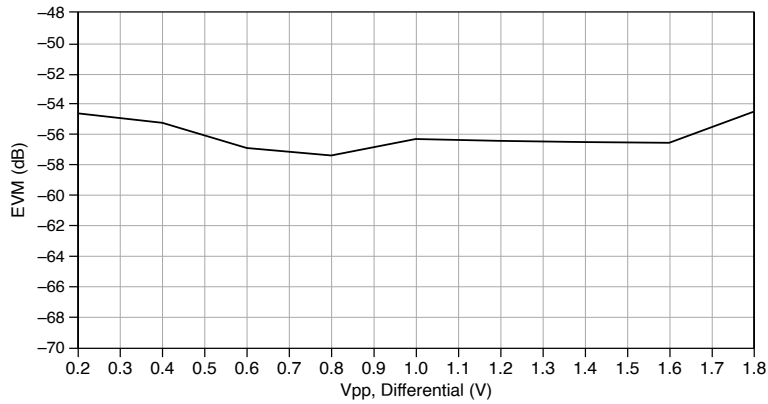
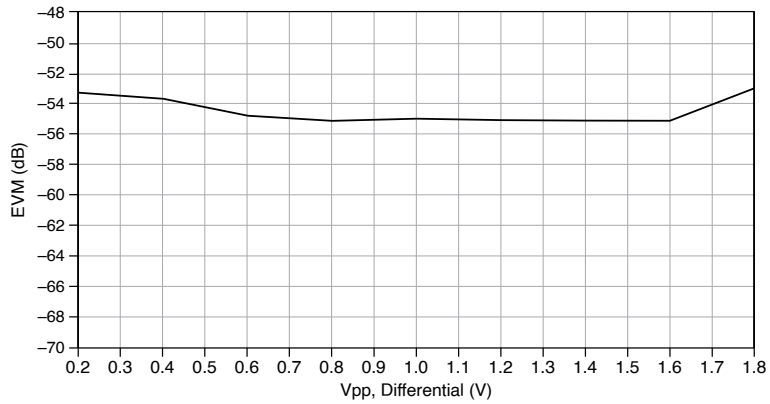


Figure 12. 802.11ac Measured EVM (160 MHz)

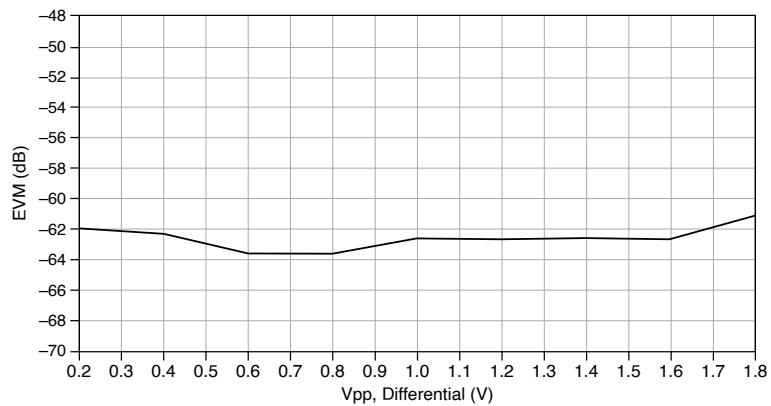


LTE

EVM (Bandwidth: 20 MHz) [\[22\]](#)

-58 dB, typical

Figure 13. LTE Measured EVM (20 MHz)



Baseband Characteristics

Analog-to-digital converters (ADCs)

I/Q data rate [\[23\]](#)

19 kS/s to 1.25 GS/s

Digital-to-analog converters (DACs)

I/Q data rate ^[24]	19 kS/s to 1.25 GS/s
-------------------------------	----------------------

Onboard FPGA

FPGA	Xilinx Virtex-7 X690T
LUTs	433,200
Flip-flops	866,400
DSP48 slices	3,600
Embedded block RAM	52.9 Mbits
Data transfers	DMA, interrupts, programmed I/O
Number of DMA channels	56

Onboard DRAM

Memory size	2 banks, 2 GB per bank
Theoretical maximum data rate	12 GB/s per bank

Onboard SRAM

Memory size	2 MB
Maximum data rate (read)	31 MB/s

Maximum data rate (write)	29 MB/s
---------------------------	---------

Front Panel I/O

I/Q IN 0

Connectors	MMPX (female)
Input coupling, per terminal	DC
Input type	Differential
Number of channels	2

Vertical Range

Input voltage range per I/Q input pin ^[25] (no damage)	-3 V to 5 V
Common-mode range ^[26]	-0.25 V to 1.5 V
Maximum vertical range	4 V _{pp} , differential

Impedance

DC differential input impedance	100 ± 10 Ω, typical
---------------------------------	---------------------

Figure 14. I/Q Input Impedance, Nominal

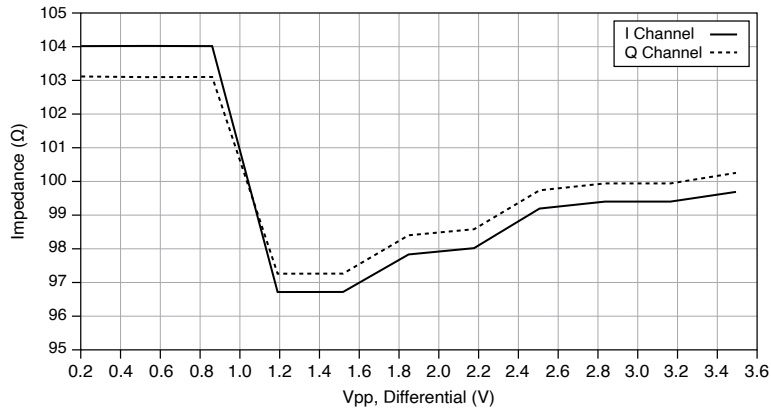
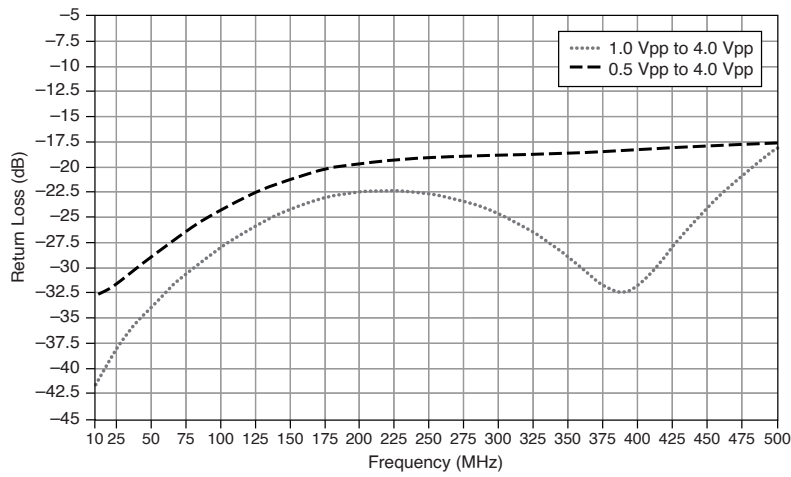


Figure 15. I/Q Input Differential Return Loss, Nominal



I/Q OUT 0

Connectors	MMPX (female)
Output coupling, per terminal	DC
Output type	differential
Number of channels	2

Vertical Range

Maximum voltage range per I/Q output pin (no damage)	$V_{com} \pm 3.5 V$
Common-mode range ^[27]	-0.25 V to 1.5 V
NI-RFSG Signal Bandwidth Setting (Complex)	Maximum Vertical Range
$\leq 160 \text{ MHz}$	3.4, nominal
$\leq 1 \text{ GHz}$	2, typical
Conditions: Into a 100Ω differential load.	

Table 30. I/Q Output Vertical Range (V_{pp} , Differential)

Impedance

DC differential output impedance	$100 \pm 10 \Omega$, typical
----------------------------------	-------------------------------

Figure 16. I/Q Output Impedance, Nominal

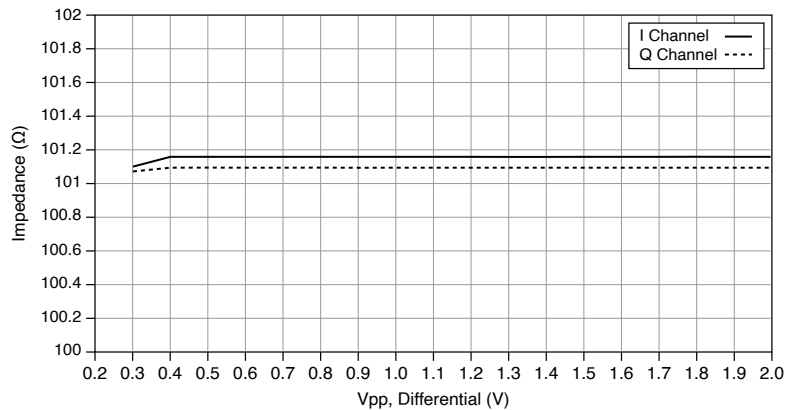
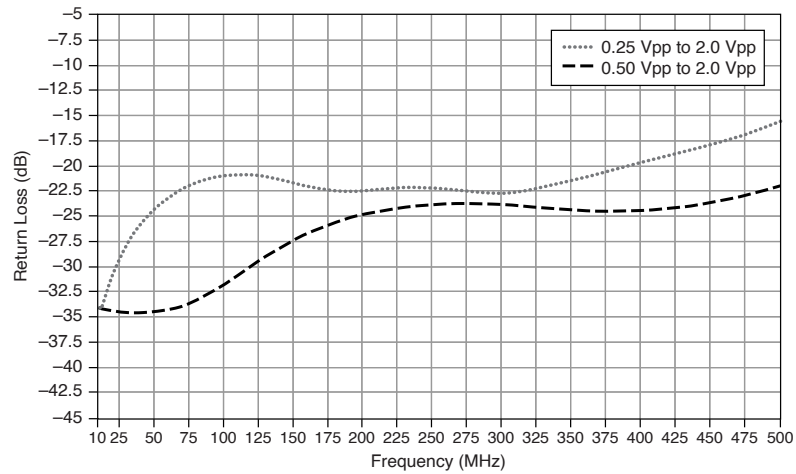


Figure 17. I/Q Output Differential Return Loss, Nominal



REF IN

Connector	MMPX (female)
Frequency	10 MHz
Tolerance ^[28]	$\pm 10 \times 10^{-6}$
Amplitude ^[29]	0.7 V _{pk-pk} to 3.3 V _{pk-pk} into 50 Ω , typical
Input impedance	50 Ω , nominal
Coupling	AC

REF OUT

Connector	MMPX (female)
Frequency	10 MHz, nominal

Amplitude	1.65 V _{pk-pk} into 50 Ω, nominal
Output impedance	50 Ω, nominal
Coupling	AC

PFI 0

Connector	MMPX (female)
Voltage levels^[30]	
Absolute maximum input range	-0.5 V to 5.5 V
V _{IL} , maximum	0.8 V
V _{IH} , minimum	2.0 V
V _{OL} , maximum	0.2 V with 100 μA load
V _{OH} , minimum	2.9 V with 100 μA load
Input impedance	10 kΩ, nominal
Output impedance	50 Ω, nominal
Maximum DC drive strength	24 mA

DIGITAL I/O

Connector	Molex Nano-Pitch I/O
-----------	----------------------

5.0 V Power	±5%, 50 mA maximum, nominal	
Signal	Type	Direction
MGT Tx± <3..0>	Xilinx Virtex-7 GTH	Output
MGT Rx± <3..0>	Xilinx Virtex-7 GTH	Input
MGT REF±	Differential	Input
DIO <1..0> ^[31]	Single-ended	Bidirectional
DIO <7..2>	Single-ended	Bidirectional
5.0 V	DC	Output
GND	Ground	—

Table 31. DIGITAL I/O Signal Characteristics

Digital I/O High Speed Serial MGT^[32]

Data rate	500 Mbps to 12 Gbps, nominal
Number of Tx channels	4
Number of Rx channels	4
I/O AC coupling capacitor	100 nF

MGT Tx± <3..0> Channels

Minimum differential output voltage ^[33]	800 mV _{pk-pk} into 100 Ω, nominal
---	---

MGT Rx± <3..0> Channels

Differential input voltage range	
≤6.6 GB/s	150 mV _{pk-pk} to 2,000 mV _{pk-pk} , nominal
>6.6 GB/s	150 mV _{pk-pk} to 1,250 mV _{pk-pk} , nominal
Differential input resistance	100 Ω, nominal

MGT Reference Clock

Clocking resources	
Internal MGT reference ^[34]	78.125 MHz to 625 MHz
Data Clock	156.25 MHz
MGT REF± Input	60 MHz to 820 MHz, nominal

MGT REF± Input

AC coupling capacitors	100 nF
Differential input resistance	100 Ω , nominal
Differential input V_{pk-pk} range	350 mV to 2000 mV, nominal
Absolute maximum input range	-1.25 V to 4.5 V ^[35]

Figure 18. DIGITAL I/O Nano-Pitch Connector

Reserved	A1	B1	5.0 V
GND	A2	B2	GND
MGT Rx+ 0	A3	B3	MGT Tx+ 0
MGT Rx- 0	A4	B4	MGT Tx- 0
GND	A5	B5	GND
MGT Rx+ 1	A6	B6	MGT Tx+ 1
MGT Rx- 1	A7	B7	MGT Tx- 1
GND	A8	B8	GND
DIO 4	A9	B9	DIO 6
DIO 5	A10	B10	DIO 7
GND	A11	B11	GND
MGT REF+ / DIO 0	A12	B12	DIO 2
MGT REF- / DIO 1	A13	B13	DIO 3
GND	A14	B14	GND
MGT Rx+ 2	A15	B15	MGT Tx+ 2
MGT Rx- 2	A16	B16	MGT Tx- 2
GND	A17	B17	GND
MGT Rx+ 3	A18	B18	MGT Tx+ 3
MGT Rx- 3	A19	B19	MGT Tx- 3
GND	A20	B20	GND
5.0 V	A21	B21	Reserved

Power Requirements

Voltage (V _{DC})	Typical Current (A)
+3.3	3.3
+12	6.0

Power is 83 W, typical. Consumption is from both PXI Express backplane power connectors. Conditions: Simultaneous generation and acquisition using NI-RFSG and NI-RFSA at 1.25 GS/s I/Q rate, 45 °C ambient temperature. Power consumption depends on FPGA image being used.

Table 32. Power Requirements

Calibration

Interval	1 year
----------	--------

Physical Characteristics

PXIe-5820 module	3U, two slot, PXI Express module 4.1 cm × 13.0 cm × 21.6 cm 1.6 in. × 5.1 in. × 8.5 in.
Weight	795 g (28.0 oz)

Environment

Maximum altitude	2,000 m (800 mbar) (at 25 °C ambient temperature)
Pollution Degree	2

Indoor use only.

Operating Environment

Ambient temperature range	0 °C to 45 °C
Relative humidity range	10% to 90%, noncondensing

Storage Environment

Ambient temperature range	-40 °C to 71 °C
Relative humidity range	5% to 95%, noncondensing

Shock and Vibration

Operating shock	30 g peak, half-sine, 11 ms pulse
Random vibration	
Operating	5 Hz to 500 Hz, 0.3 g _{rms}
Nonoperating	5 Hz to 500 Hz, 2.4 g _{rms}

Compliance and Certifications

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1

Note For safety certifications, refer to the product label or the [Product Certifications and Declarations](#) section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Basic immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- AS/NZS CISPR 11: Group 1, Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions

Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia, and New Zealand (per CISPR 11), Class A equipment is intended for use only in heavy-industrial locations.

Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency energy for the treatment of material or inspection/analysis purposes.

Note For EMC declarations, certifications, and additional information, refer to the [Product Certifications and Declarations](#) section.

Product Certifications and Declarations


Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI products, visit ni.com/product-certifications, search by model number, and click the appropriate link.

Environmental Management


NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the **Engineering a Healthy Planet** web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

-  **Waste Electrical and Electronic Equipment (WEEE)**—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法（中国 RoHS）

-  **中国 RoHS**—NI 符合中国电子信息产品中限制使用某些有害物质指令(RoHS)。关于 NI 中国 RoHS 合规性信息，请登录 ni.com/environment/rohs_china。(For information about China RoHS compliance, go to ni.com/environment/rohs_china.)

¹ Complex equalized bandwidth is the combined bandwidth of I and Q channels. Valid only when using identical gain and termination settings for each I/Q channel.

² Referenced to 10 MHz. Digital equalization enabled. Valid only when using identical gain and termination settings for each I/Q channel.

³ Measured at 23 °C with 0 V common-mode and 1 V_{pp} vertical range, differential.

⁴ Nominal settling time is for max common-mode change.

- 5 Terminated with a 100 Ω differential impedance. Linear scale used for frequency axis.
- 6 Terminated with a 100 Ω differential impedance. Log scale used for frequency axis.
- 7 Conditions: Measured with a -2 dBFS CW tone.
- 8 Conditions: Measured with a -2 dBFS CW tone.
- 9 Conditions: 100 Ω differential load.
- 10 Measured at 23 °C with 0 V common-mode and 1 V_{pp} vertical range, differential.
- 11 Nominal settling time is for max common-mode voltage change.
- 12 Conditions: Measured with a -1 dBFS CW tone.
- 13 Conditions: Measured in loopback with a -1 dBFS CW tone. The I/Q input vertical range is set to twice the I/Q output vertical range.
- 14 Measured at 23 °C. Digital equalization enabled. Valid only when using identical gain and termination settings for each I/Q channel. Measured using short phase matched loopback cables <1 ps.
- 15 Measured at 23 °C with both I/Q In and I/Q Out common-mode voltage set to 0 V and with I/Q In vertical range set to 2.0 V_{pp}, differential.
- 16 Measured at 23 °C with both I/Q In and I/Q Out common-mode voltage set to 0 V and with I/Q In vertical range set to 2.0 V_{pp}, differential.
- 17 Measured at 23 °C with both I/Q In and I/Q Out common-mode voltage set to 0 V and with I/Q In vertical range set to 2.0 V_{pp}, differential.
- 18 Measured at 23 °C with both I/Q In and I/Q Out common-mode voltage set to 0 V and with I/Q In vertical range set to 2.0 V_{pp}, differential.

- 19 Loopback with phase matched cables <1 ps; transmit power auto-leveled based on real-time average power measurements; MCS=11.
- 20 Loopback with phase matched cables <1 ps; transmit power auto-leveled based on real-time average power measurements; MCS=11.
- 21 Loopback with phase matched cables <1 ps; transmit power auto-leveled based on real-time average power measurements; MCS=11.
- 22 Loopback with phase matched cables <1 ps; transmit power auto-leveled based on real-time average power measurements.
- 23 I/Q data rates lower than 1.25 GS/s are achieved using fractional decimation.
- 24 I/Q data rates lower than 1.25 GS/s are achieved using fractional interpolation.
- 25 Common-mode voltage plus peak AC voltage.
- 26 Valid for all V_{pp} differential levels with a 100 Ω differential source.
- 27 Valid for all V_{pp} , differential levels.
- 28 **Frequency Accuracy = Tolerance \times Reference Frequency**
- 29 Jitter performance improves with increased slew rate of input signal.
- 30 Voltage levels are guaranteed by design through the digital buffer specifications.
- 31 Pins are multiplexed with MGT REF \pm .
- 32 For detailed FPGA and High Speed Serial Link specifications, refer to Xilinx documentation.
- 33 When transmitter output swing is set to the maximum setting.
- 34 Internal MGT Reference is derived from the Sample Clock PLL. Available frequencies are 2.5 GHz / \mathbf{N} , where $4 \leq \mathbf{N} \leq 32$. Set via MGT component level IP (CLIP).

³⁵ Absolute maximum levels at input, prior to AC coupling capacitors.